## **Supporting Information**

# **Electrospray Prepared Flexible CsPbBr<sub>3</sub> Perovskite Film for efficient** X-ray Detection

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Fig. S1 (a-b) SEM images of the low-magnification morphology of the film at 160 °C and 80 °C.

### Calculation of resistivity for interdigital detectors



Fig. S2 Schematic diagram of partial cycle interdigital electrode

$$\frac{1}{R'} = \frac{4}{\frac{b}{c}(\frac{2c}{d-c}+1)R_f} + \frac{4}{\frac{c}{b}(\frac{2b}{a}+1)R_f}$$
$$\frac{1}{R} = \frac{n}{R'}$$
$$R_f = \frac{\rho}{\delta}$$

*R'* is single periodic parallel resistance and  $R_f$  is square resistance. *R* is total resistance of the CsPbBr<sub>3</sub> film from the experiment and *n* is the prepetition period of the parallel resistance.  $\delta$  is the thickness of the film and  $\rho$  is resistivity of the film. Specifically, the values of a, b, c for the interdigital electrode are 0.5 mm. The value of *d* is 6.5 mm, the repetition period of electrode structure (*n*) is 4.5 and the thickness of the film is 3 µm.



Fig. S3 (a-d) I-V curves of CsPbBr3 film under different background voltage.

#### Calculation of the average attenuation efficiency $(\bar{\epsilon})$ of CsPbBr3 film

X-ray tube voltage determines the energy of the X-ray photons. The source of Xray tube voltages used in this work is 20 kV<sub>p</sub> and 50 kV<sub>p</sub> and the energy distributions of 20 kV<sub>p</sub> and 50 kV<sub>p</sub> were evaluated utilizing the software (SPEKTR 3.0) downloaded from <u>http://istar.jhu.edu/downloads/</u>, as shown in Fig. S4a. The average X-ray photon energy of 20 kV<sub>p</sub> and 50 kV<sub>p</sub> are 17.9 keV and 29.0 keV separately. Considering that CsPbBr<sub>3</sub> film cannot have sufficient thickness (3 µm) to absorb X-ray photons, the average attenuation efficiency ( $\bar{\epsilon}$ ) is needed to carefully calculate below.

Initially, the single energy X-ray attenuation efficiency ( $\varepsilon$ ) can be calculated by  $\varepsilon = 1 - e^{-\mu x}$ , where x is the thickness of CsPbBr<sub>3</sub> film and  $\mu$  is the absorption coefficient of CsPbBr<sub>3</sub> film. Fig. S4b reveals the absorption coefficient ( $\mu$ ) of CsPbBr<sub>3</sub> originated from X-COM database by NIST. When the thickness of CsPbBr<sub>3</sub> film is 3  $\mu$ m, the diagram of the attenuation efficiency versus incident photon energy is illustrated in Fig. S4c. Therefore, to evaluate the average attenuation efficiency of CsPbBr<sub>3</sub>, the relationship between the attenuation efficiency versus thickness with the tube voltage of 20 kV<sub>p</sub> and 50 kV<sub>p</sub>, is exhibited in Fig. S4d. The average attenuation efficiency ( $\overline{\varepsilon}$ ) of CsPbBr<sub>3</sub> film (3  $\mu$ m) results for 20 kV<sub>p</sub> and 50 kV<sub>p</sub> are 10.51 % and 2.71 %.



**Fig. S4** (a) X-ray photon energy distribution at the tube voltage of 20 kV<sub>p</sub> and 50 kV<sub>p</sub>. (b) Absorption coefficient ( $\mu$ ) of CsPbBr<sub>3</sub> ranged from 1-100 keV utilizing X-COM by NIST. (c) Calculated attenuation efficiency ( $\varepsilon$ ) of CsPbBr<sub>3</sub> with a thickness of 3  $\mu$ m versus X-ray photon energy. (d) Calculated attenuation efficiency ( $\varepsilon$ ) of CsPbBr<sub>3</sub> versus thickness with the tube voltage of 20 kV<sub>p</sub> and 50 kV<sub>p</sub>.



Fig. S5 The current density as a function of absorbed dose rate with 9V bias illuminated by the X-ray tube voltage of  $20kV_p$ .



**Fig. S6** (a)(c)(e)(g) I-t curves of CsPbBr<sub>3</sub> detector under 1, 3, 5 and 7V bias illuminated under the X-ray tube voltage of 20 kV<sub>p</sub>. (b)(d)(f)(h) X-ray current density as a function of absorbed dose rate with 1, 3, 5 and 7V bias under the X-ray tube voltage of  $20 \text{ kV}_p$ .



**Fig. S7** (a)(c)(e)(g)(i) I-t curves of CsPbBr<sub>3</sub> detector under 1, 3, 5, 7 and 9V bias illuminated under the X-ray tube voltage of 50 kV<sub>p</sub>. (b)(d)(f)(h)(j) X-ray current density as a function of absorbed dose rate with 1, 3, 5, 7 and 9V bias under the X-ray tube voltage of  $50 \text{ kV}_p$ .



Fig. S8 A line diagram of sensitivity as a function of bias voltage under the X-ray source of 50 kVp.



**Fig. S9** I-t curves of the CsPbBr<sub>3</sub> detector at 1, 3, 5, 7, 9 V bias under the 20 kV<sub>p</sub> Xray with the dose rate of 14.61, 37.47, 80.74  $\mu$ Gy<sub>air</sub>·s<sup>-1</sup>.